Search Notes

App	licat	ion/	Con	troi	No.

10/767,726 Examiner

Thomas D. Lee

Applicant(s)/Patent under Reexamination

OGAWA, HIDEHIKO
Art Unit

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Class	Subclass	Date	Examiner		
358	1.15, 402, 440	9/22/2006	TDL		
379	100.01	9/22/2006	TDL		
379	100.08	9/22/2006	TDL		
379	100.13	9/22/2006	TDL		
379	100.17	9/22/2006	TDL		
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